

Notice of References Cited		Application/Control No. 10/535,452	Applicant(s)/Patent Under Reexamination OGAWA ET AL.	
		Examiner Duy-Vu N. Deo	Art Unit 1792	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,068,152	11-1991	Maro et al.	428/408
*	B	US-2004/0166376	08-2004	Kirino et al.	428/694.0TM
*	C	US-6,730,421	05-2004	Kirino et al.	428/831.2
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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